


<b>Search Notes</b>  	<b>Application/Control No.</b>  10596708	<b>Applicant(s)/Patent Under Reexamination</b>  PINA, JEAN-BENOIT
	<b>Examiner</b>  MARK D FEATHERSTONE	<b>Art Unit</b>  2423

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Searched 725/81 and 725 general	4/6/2010	MF
Consult Chris Grant on 112 analysis for claims 1 and 5-7	4/7/2010	MF
Consulted Drew Koenig and Chris Grant on duplicate claims 5-6	4/7/2010	MF
EDAN inventor search	4/7/2010	MF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--